

Dual, 12-Bit, 3+3 or 2+2 Channel, Simultaneous Sampling Analog-to-Digital Converter

FEATURES

- Six Pseudo- or Four Fully Differential Inputs
- SNR: 71.7dB, THD: -87dB
- Programmable Channel Sequencer
- Programmable and Buffered Internal 2.5V Reference
- Flexible Power-Down Features
- Variable Power-Supply Ranges: 2.7V to 5.5V
- Low-Power Operation: 44mW Maximum at 5V
- Operating Temperature Range:
-40°C to +125°C
- Pin-Compatible Upgrade for the [ADS7862](#)

APPLICATIONS

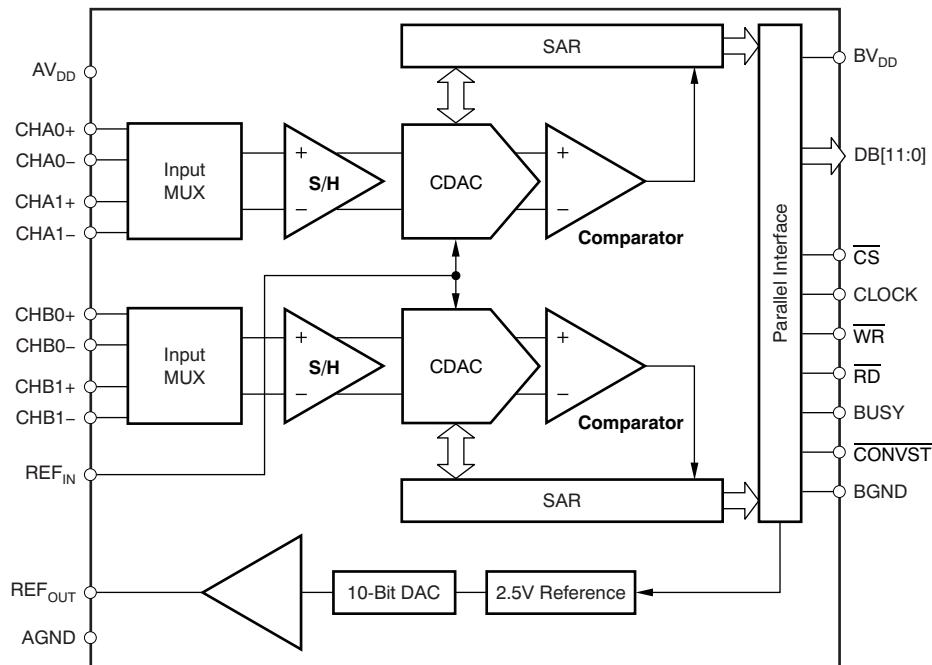
- Motor Control
- Multi-Axis Positioning Systems
- Three-Phase Power Control

DESCRIPTION

The ADS7865 is a dual, 12-bit, 2MSPS analog-to-digital converter (ADC) with four fully differential or six pseudo-differential input channels grouped into two pairs for high-speed, simultaneous signal acquisition. Inputs to the sample-and-hold (S/H) amplifiers are fully differential and are maintained differentially to the input of the ADC. This architecture provides excellent common-mode rejection of 72dB at 100kHz, which is a critical performance characteristic in noisy environments.

The ADS7865 is pin-compatible with the ADS7862, but offers additional features such as a programmable channel sequencer and reference output, flexible supply voltage (2.7V to 5.5V for AV_{DD} and BV_{DD}), a pseudo-differential input multiplexer with three channels per ADC, and several power-down features.

The ADS7865 is offered in a TQFP-32 package. It is specified over the extended operating temperature range of -40°C to +125°C.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION⁽¹⁾

| PRODUCT | PACKAGE-LEAD | PACKAGE DESIGNATOR | ORDERING NUMBER | TRANSPORT MEDIA, QUANTITY |
|----------|--------------|--------------------|-----------------|---------------------------|
| ADS7865I | TQFP-32 | PBS | ADS7865IPBS | Tray, 250 |
| | | | ADS7865IPBSR | Tray, 2500 |

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Over operating free-air temperature range, unless otherwise noted.

| | | ADS7865 | UNIT |
|---|---|--------------------------|------|
| Supply voltage, AV _{DD} to AGND | | -0.3 to +6 | V |
| Supply voltage, BV _{DD} to BGND | | -0.3 to +6 | V |
| Supply voltage, BV _{DD} to AV _{DD} | | 1.5 × AVDD | V |
| Analog and reference input voltage with respect to AGND | | AGND – 0.3 to AVDD + 0.3 | V |
| Digital input voltage with respect to BGND | | BGND – 0.3 to BVDD + 0.3 | V |
| Ground voltage difference AGND – BGND | | 0.3 | V |
| Input current to all pins except power-supply pins | | -10 to +10 | mA |
| Maximum virtual junction temperature, T _J | | +150 | °C |
| ESD ratings | Human body model (HBM), JEDEC standard 22, test method A114-C.01, all pins | ±4000 | V |
| | Charged device model (CDM), JEDEC standard 22, test method C101, all pins | ±1500 | V |

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

RECOMMENDED OPERATING CONDITIONS

Over operating free-air temperature range, unless otherwise noted.

| PARAMETER | ADS7865 | | | UNIT |
|---|--------------------|-----|-------------------|------|
| | MIN | NOM | MAX | |
| Supply voltage, AV _{DD} to AGND | 2.7 | 5.0 | 5.5 | V |
| Supply voltage, BV _{DD} to BGND | Low voltage levels | 2.7 | 3.6 | V |
| | 5V logic levels | 4.5 | 5.0 | 5.5 |
| Reference input voltage on REF _{IN} | 0.5 | 2.5 | 2.525 | V |
| Analog differential input voltage (CHXX+) – (CHXX–) | –V _{REF} | | +V _{REF} | V |
| Operating ambient temperature range, T _A | –40 | | +125 | °C |

THERMAL CHARACTERISTICS⁽¹⁾

Over operating free-air temperature range, unless otherwise noted.

| PARAMETER | | | ADS7865 | UNIT |
|-----------------|---|---------------------------|---------|------|
| θ _{JA} | Junction-to-air thermal resistance | High-K thermal resistance | 56.4 | °C/W |
| θ _{JC} | Junction-to-case thermal resistance | | 20.8 | °C/W |
| P _D | Device power dissipation at AVDD = 5V and BVDD = 3.3V | | 44 | mW |

(1) Tested in accordance with the High-K thermal metric definitions of EIA/JESD51-3 for leaded surface-mount packages with a 3×3 via array.

ELECTRICAL CHARACTERISTICS

At $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$; over entire power-supply voltage range, $V_{\text{REF}} = 2.5\text{V}$ (internal), $f_{\text{CLK}} = 32\text{MHz}$, and $f_{\text{DATA}} = 2\text{MSPS}$, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | ADS7865 | | | UNIT | |
|--------------------------|--|---|--------------------|------------------------|------------------------------|--|
| | | MIN | TYP ⁽¹⁾ | MAX | | |
| RESOLUTION | | 12 | | | Bits | |
| ANALOG INPUT | | | | | | |
| FSR | Full-scale differential input range | (CHxx+) – (CHxx–) | $-V_{\text{REF}}$ | $+V_{\text{REF}}$ | V | |
| V_{IN} | Absolute input voltage | CHxx+ or CHxx– to AGND | –0.1 | $AV_{\text{DD}} + 0.1$ | V | |
| C_{IN} | Input capacitance | CHxx+ or CHxx– to AGND | 2 | | pF | |
| C_{ID} | Differential input capacitance | | 4 | | pF | |
| I_{IL} | Input leakage current | | –50 | 50 | nA | |
| CMRR | Common-mode rejection ratio | Both ADCs, dc to 100kHz | 72 | | dB | |
| DC ACCURACY | | | | | | |
| INL | Integral nonlinearity | –40°C < T_A < +125°C | –1.25 | ± 0.6 | +1.25 | |
| | | –40°C < T_A < +85°C | –1 | ± 0.5 | +1 | |
| DNL | Differential nonlinearity ⁽²⁾ | | –1 | ± 0.4 | +1 | |
| V_{OS} | Input offset error | | –3 | ± 0.5 | +3 | |
| | Match | | –3 | ± 0.5 | +3 | |
| dV_{OS}/dT | Input offset thermal drift | | | ±2 | $\mu\text{V}/^\circ\text{C}$ | |
| G_{ERR} | Gain error ⁽²⁾ | | –0.6 | 0.15 | +0.6 | |
| | Match | | –0.6 | ± 0.1 | +0.6 | |
| G_{ERR}/dT | Gain error thermal drift | | | ±2 | $\text{ppm}/^\circ\text{C}$ | |
| PSRR | Power-supply rejection ratio | $AV_{\text{DD}} = 5\text{V}$ | 70 | | dB | |
| AC ACCURACY | | | | | | |
| SINAD | Signal-to-noise + distortion | $V_{\text{IN}} = 5\text{V}_{\text{PP}}$ at 100kHz | 69 | 71.3 | dB | |
| SNR | Signal-to-noise ratio | $V_{\text{IN}} = 5\text{V}_{\text{PP}}$ at 100kHz | 70 | 71.7 | dB | |
| THD | Total harmonic distortion | $V_{\text{IN}} = 5\text{V}_{\text{PP}}$ at 100kHz | | –87 | –74 | |
| SFDR | Spurious-free dynamic range | $V_{\text{IN}} = 5\text{V}_{\text{PP}}$ at 100kHz | 74 | 88 | dB | |
| SAMPLING DYNAMICS | | | | | | |
| t_{CONV} | Conversion time per ADC | 1MHz < f_{CLK} ≤ 32MHz | 13 | | Clocks | |
| t_{ACQ} | Acquisition time | | 62.5 | | ns | |
| f_{DATA} | Data rate | 1MHz < f_{CLK} ≤ 32MHz | 62.5 | 2000 | kSPS | |
| t_A | Aperture delay | | | 6 | ns | |
| | Match | | 50 | | ps | |
| t_{AJIT} | Aperture jitter | | 50 | | ps | |
| f_{CLK} | Clock frequency on CLOCK | | 1 | 32 | MHz | |

(1) All values at $T_A = +25^\circ\text{C}$.

(2) Ensured by design, not production tested.

ELECTRICAL CHARACTERISTICS (continued)

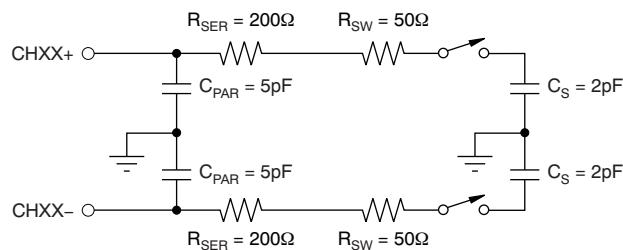
At $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$; over entire power-supply voltage range, $V_{\text{REF}} = 2.5\text{V}$ (internal), $f_{\text{CLK}} = 32\text{MHz}$, and $f_{\text{DATA}} = 2\text{MSPS}$, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | ADS7865 | | | UNIT | |
|-----------------------------------|--|-----------------------------------|-----------------------------|-----------------------------|-----------------------|-----|
| | | MIN | TYP ⁽¹⁾ | MAX | | |
| INTERNAL VOLTAGE REFERENCE | | | | | | |
| Resolution | Reference output DAC resolution | 10 | | | Bits | |
| V_{REFOUT} | Reference output voltage | 0.496 | 2.515 | 2.515 | V | |
| | | 2.485 | 2.500 | 2.515 | V | |
| | | 2.495 | 2.500 | 2.505 | V | |
| dV_{REFOUT}/dT | Reference voltage drift | | ± 10 | | ppm/ $^\circ\text{C}$ | |
| DNL_{DAC} | DAC differential linearity error | -4 | ± 1 | 4 | LSB | |
| INL_{DAC} | DAC integral linearity error | -4 | ± 0.5 | 4 | LSB | |
| V_{OSDAC} | DAC offset error | $V_{\text{REFOUT}} = 0.5\text{V}$ | -4 | ± 1 | 4 | LSB |
| PSRR | Power-supply rejection ratio | | 73 | | dB | |
| I_{REFOUT} | Reference output dc current | | -2 | +2 | mA | |
| I_{REFSC} | Reference output short-circuit current | | 50 | | mA | |
| t_{REFON} | Reference output settling time | | 0.5 | | ms | |
| VOLTAGE REFERENCE INPUT | | | | | | |
| V_{REF} | Reference input voltage range | 0.5 | 2.525 | 2.525 | V | |
| I_{REF} | Reference input current | 50 | | | μA | |
| C_{REF} | Reference input capacitance | 10 | | | pF | |
| DIGITAL INPUTS | | | | | | |
| | Logic family | CMOS | | | | |
| V_{IH} | High-level input voltage | | $0.7 \times BV_{\text{DD}}$ | $BV_{\text{DD}} + 0.3$ | V | |
| V_{IL} | Low-level input voltage | | -0.3 | $0.3 \times BV_{\text{DD}}$ | V | |
| I_{IN} | Input current | $V_I = BV_{\text{DD}}$ to BGND | -50 | +50 | nA | |
| C_I | Input capacitance | | 5 | | pF | |
| DIGITAL OUTPUTS | | | | | | |
| | Logic family | CMOS | | | | |
| V_{OH} | High-level output voltage | $I_{\text{OH}} = -100\mu\text{A}$ | $BV_{\text{DD}} - 0.2$ | | V | |
| V_{OL} | Low-level output voltage | $I_{\text{OH}} = 100\mu\text{A}$ | | 0.2 | V | |
| I_{OZ} | High-impedance-state output current | $V_I = BV_{\text{DD}}$ to BGND | -50 | +50 | nA | |
| C_O | Output capacitance | | 5 | | pF | |
| C_L | Load capacitance | | 30 | | pF | |

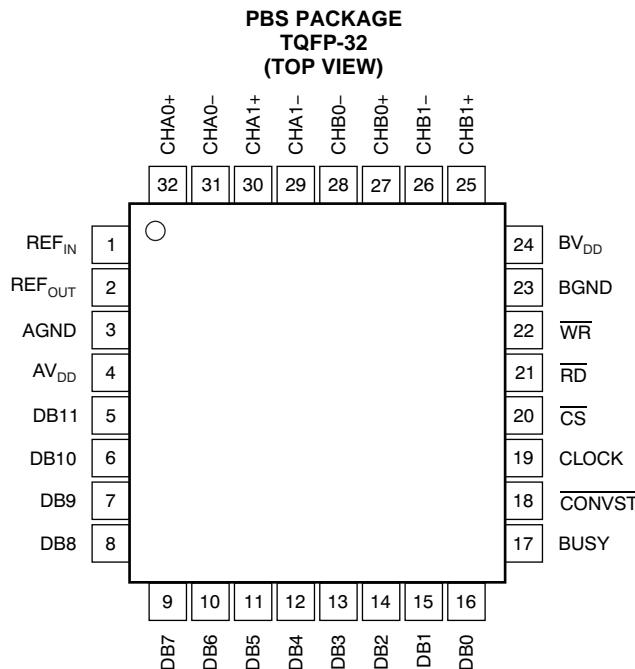
ELECTRICAL CHARACTERISTICS (continued)

At $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$; over entire power-supply voltage range, $V_{\text{REF}} = 2.5\text{V}$ (internal), $f_{\text{CLK}} = 32\text{MHz}$, and $f_{\text{DATA}} = 2\text{MSPS}$, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | ADS7865 | | | UNIT |
|---------------------|---------------------------|--|--------------------|-------|------|
| | | MIN | TYP ⁽¹⁾ | MAX | |
| POWER SUPPLY | | | | | |
| AV_{DD} | Analog supply voltage | AV_{DD} to AGND | 2.7 | 5.0 | 5.5 |
| BV_{DD} | Buffer I/O supply current | BV_{DD} to BGND | 2.7 | 3.0 | 5.5 |
| AI_{DD} | Analog supply current | $AV_{\text{DD}} = 2.7\text{V}$ | 4.1 | 6.0 | mA |
| | | $AV_{\text{DD}} = 5\text{V}$ | 5.6 | 7.5 | mA |
| | | $AV_{\text{DD}} = 2.7\text{V}$, NAP power-down | 0.9 | 1.6 | mA |
| | | $AV_{\text{DD}} = 5\text{V}$, NAP power-down | 1.1 | 1.8 | mA |
| | | $AV_{\text{DD}} = 2.7\text{V}$, deep power-down | | 0.001 | mA |
| | | $AV_{\text{DD}} = 5\text{V}$, deep power-down | | 0.001 | mA |
| BI_{DD} | Buffer I/O supply current | $BV_{\text{DD}} = 2.7\text{V}$, $C_{\text{LOAD}} = 10\text{pF}$ | 0.6 | 1.7 | mA |
| | | $BV_{\text{DD}} = 3.3\text{V}$, $C_{\text{LOAD}} = 10\text{pF}$ | 0.8 | 1.9 | mA |
| P_{D} | Power dissipation | $AV_{\text{DD}} = 2.7\text{V}$, $BV_{\text{DD}} = 2.7\text{V}$ | 12.7 | 21 | mA |
| | | $AV_{\text{DD}} = 5.0\text{V}$, $BV_{\text{DD}} = 3.0\text{V}$ | 30.6 | 44 | mW |

EQUIVALENT INPUT CIRCUIT


DEVICE INFORMATION

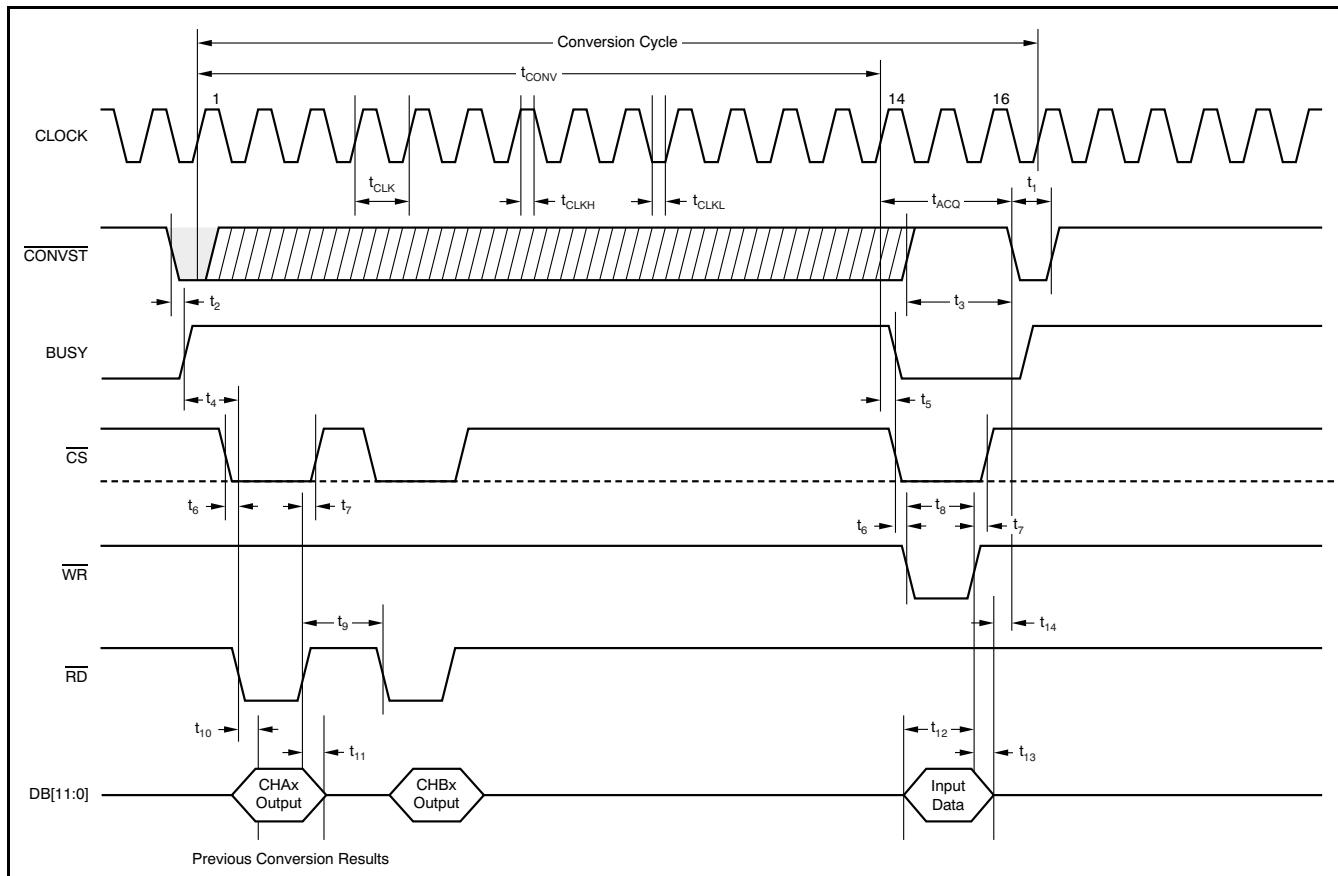


TERMINAL FUNCTIONS

| PIN NUMBER | NAME | DESCRIPTION |
|------------|--------------------|---|
| 1 | REF _{IN} | Reference voltage input. A ceramic capacitor of 470nF (min) is required at this terminal. |
| 2 | REF _{OUT} | Reference voltage output. The programmable internal voltage reference output is available on this pin. |
| 3 | AGND | Analog ground. Connect to analog ground plane. |
| 4 | AV _{DD} | Analog power supply, 2.7V to 5.5V. Decouple to AGND with a 1 μ F ceramic capacitor. |
| 5 | DB11 | Data bit 11, MSB |
| 6 | DB10 | Data bit 10 |
| 7 | DB9 | Data bit 9 |
| 8 | DB8 | Data bit 8 |
| 9 | DB7 | Data bit 7 |
| 10 | DB6 | Data bit 6 |
| 11 | DB5 | Data bit 5 |
| 12 | DB4 | Data bit 4 |
| 13 | DB3 | Data bit 3 |
| 14 | DB2 | Data bit 2 |
| 15 | DB1 | Data bit 1 |
| 16 | DB0 | Data bit 0 |
| 17 | BUSY | ADC busy indicator. BUSY goes high when the inputs are in hold mode and returns to low after the conversion has been finished. |
| 18 | CONVST | Conversion start. The ADC switches from the sample into the hold mode on the falling edge of CONVST, independent of the status of the CLOCK. The conversion itself starts with the next rising edge of CLOCK. |
| 19 | CLOCK | External clock input. |
| 20 | CS | Chip select. When low, the parallel interface of the device is active; when high, input signals are ignored and output signals are 3-state. |
| 21 | RD | Read data. Falling edge active synchronization pulse for the parallel data outputs. RD only triggers, when CS is low. |
| 22 | WR | Write data. Rising edge latches in the parallel data inputs. WR only triggers, when CS is low. |

TERMINAL FUNCTIONS (continued)

| PIN NUMBER | NAME | DESCRIPTION |
|------------|------------------|---|
| 23 | BGND | Buffer I/O ground. Connect to digital ground plane. |
| 24 | BV _{DD} | Buffer I/O power supply, 2.7V to 5.5V. Decouple to BGND with a 1 μ F ceramic capacitor. |
| 25 | CHB1+ | Noninverting analog input channel B1 |
| 26 | CHB1- | Inverting analog input channel B1 |
| 27 | CHB0+ | Noninverting analog input channel B0 |
| 28 | CHB0- | Inverting analog input channel B0 |
| 29 | CHA1- | Inverting analog input channel A1 |
| 30 | CHA1+ | Noninverting analog input channel A1 |
| 31 | CHA0- | Inverting analog input channel A0 |
| 32 | CHA0+ | Noninverting analog input channel A0 |

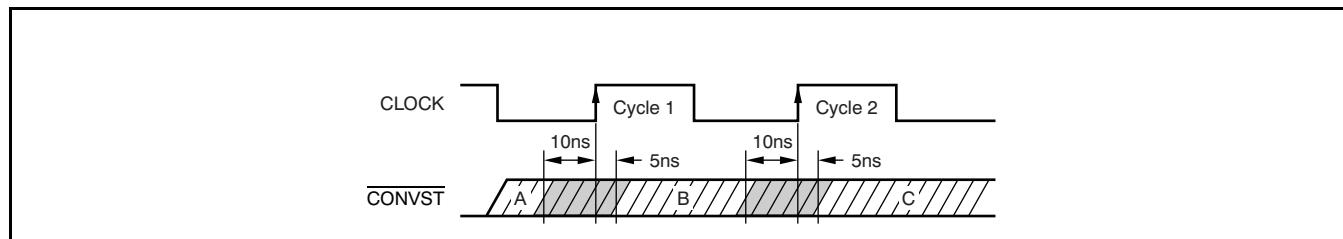
TIMING CHARACTERISTICS

Figure 1. Interface Timing Diagram

TIMING REQUIREMENTS⁽¹⁾

| PARAMETER | TEST CONDITIONS | ADS7865 | | | UNIT |
|------------|--|---------|-----|------|-----------|
| | | MIN | TYP | MAX | |
| t_{CONV} | $f_{CLOCK} = 32\text{MHz}$ See Figure 1 | | 13 | | t_{CLK} |
| t_{ACQ} | | 62.5 | | | ns |
| f_{CLK} | | 1 | | 32 | MHz |
| t_{CLK} | | 31.25 | | 1000 | ns |
| t_{CLKL} | | 9.4 | | | ns |
| t_{CLKH} | | 9.4 | | | ns |
| t_1 | | 20 | | | ns |
| t_2 | | 3 | | | ns |
| t_3 | | 20 | | | ns |
| t_4 | | 1 | | | t_{CLK} |
| t_5 | | 3 | | | ns |
| t_6 | | 0 | | | ns |
| t_7 | | 0 | | | ns |
| t_8 | | 10 | | | ns |
| t_9 | | 10 | | | ns |
| t_{10} | | | 20 | | ns |
| t_{11} | | 5 | | | ns |
| t_{12} | | 10 | | | ns |
| t_{13} | | 5 | | | ns |
| t_{14} | | 31.25 | | | ns |

(1) All input signals are specified with $t_R = t_F = 1.5\text{ns}$ (10% to 90% of BV_{DD}) and timed from a voltage level of $(V_{IL} + V_{IH})/2$.

(2) Not applicable in auto-Nap power-down mode.



NOTE: All $\overline{\text{CONVST}}$ commands that occur more than 10ns before the rising edge of cycle '1' of the external clock (Region 'A') initiate a conversion on the rising edge of cycle '1'. All $\overline{\text{CONVST}}$ commands that occur 5ns after the rising edge of cycle '1' or 10ns before the rising edge of cycle '2' (Region 'B') initiate a conversion on the rising edge of cycle '2'. All $\overline{\text{CONVST}}$ commands that occur 5ns after the rising edge of cycle '2' (Region 'C') initiate a conversion on the rising edge of the next clock period.

The $\overline{\text{CONVST}}$ pin should never be switched from LOW to HIGH in the region 10ns before the rising edge of the CLOCK and 5ns after the rising edge (gray areas). If $\overline{\text{CONVST}}$ is toggled in this gray area, the conversion could begin on either the same rising edge of the CLOCK or the following edge.

Figure 2. $\overline{\text{CONVST}}$ Timing

TYPICAL CHARACTERISTICS

Over the entire supply voltage range; $V_{REF} = 2.5V$ (internal), $f_{CLK} = 32MHz$, and $f_{DATA} = 2MSPS$, unless otherwise noted.

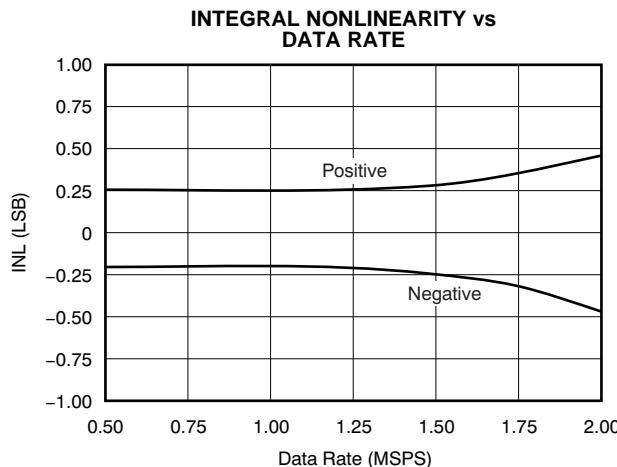


Figure 3.

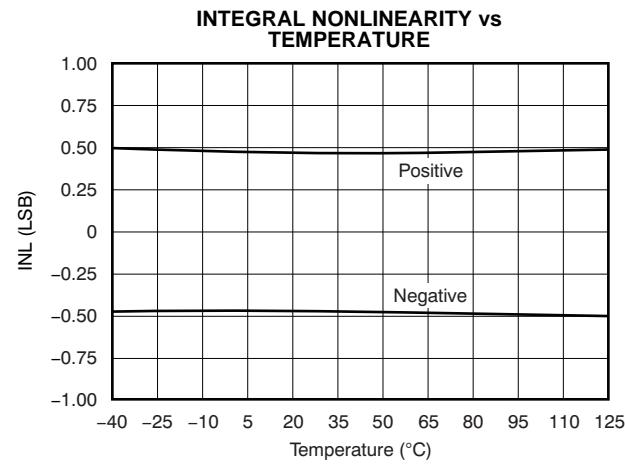


Figure 4.

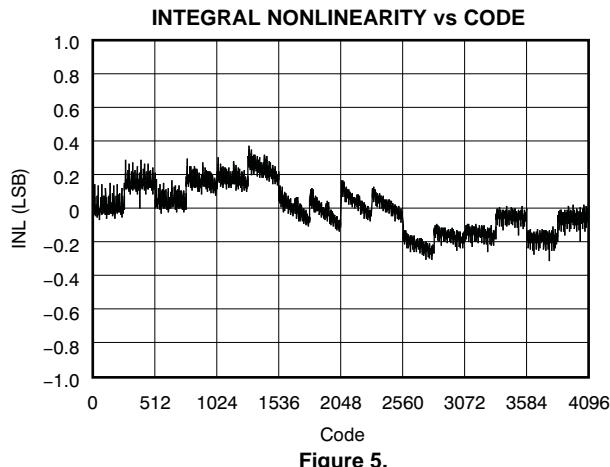


Figure 5.

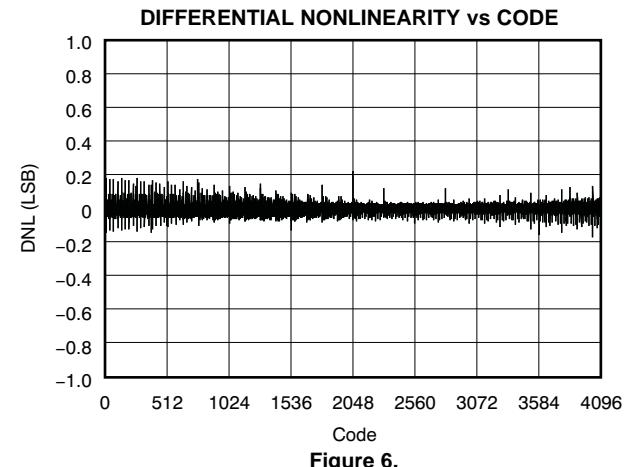


Figure 6.

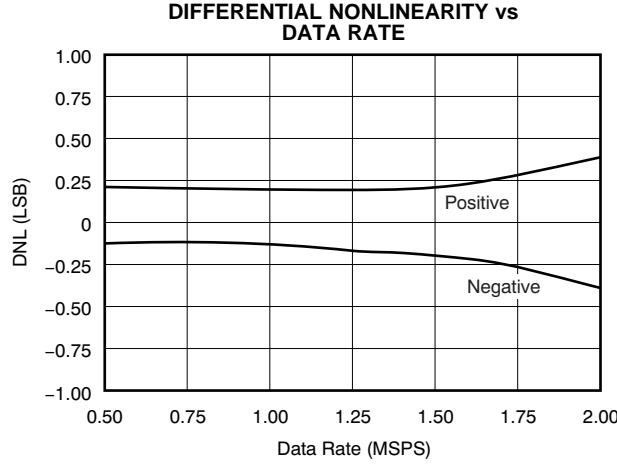


Figure 7.

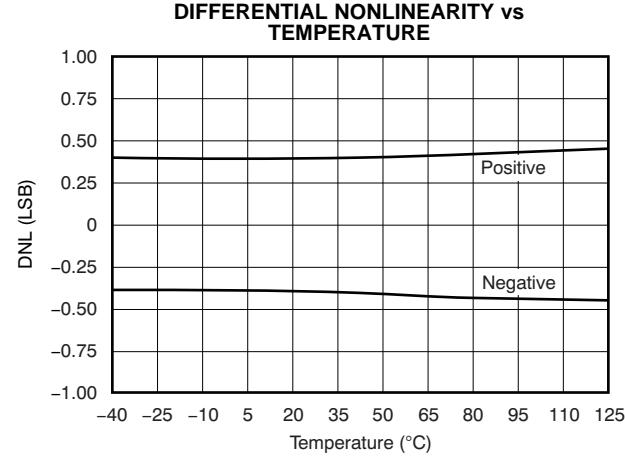


Figure 8.

TYPICAL CHARACTERISTICS (continued)

Over the entire supply voltage range; $V_{REF} = 2.5V$ (internal), $f_{CLK} = 32MHz$, and $f_{DATA} = 2MSPS$, unless otherwise noted.

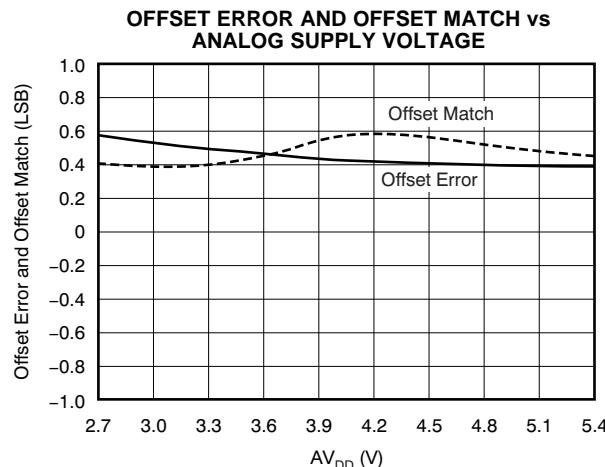


Figure 9.

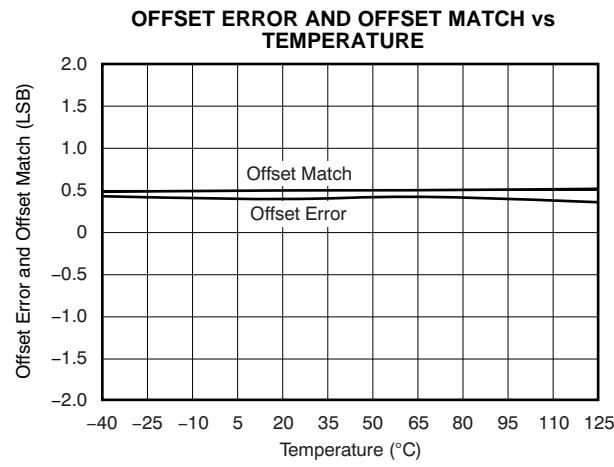


Figure 10.

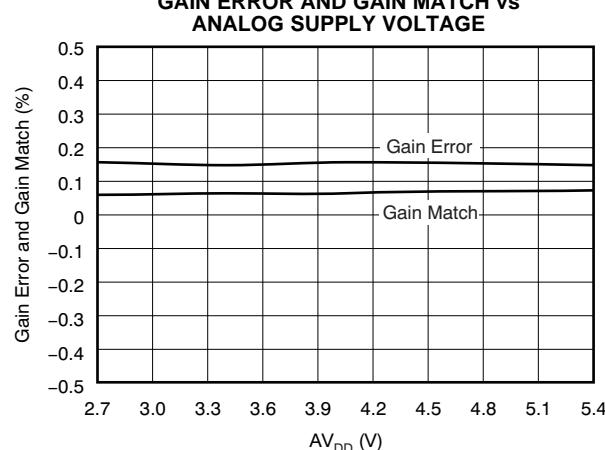


Figure 11.

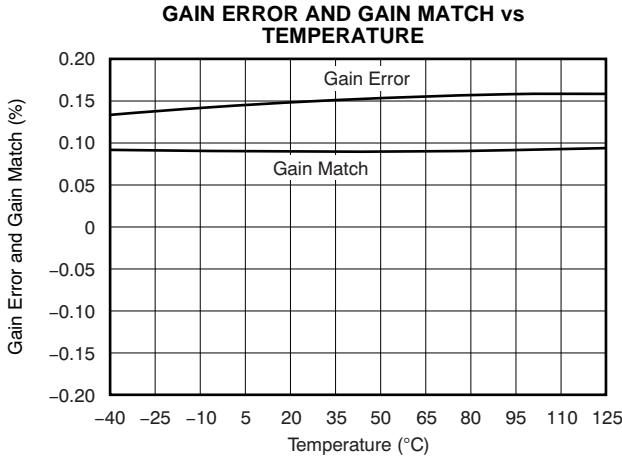


Figure 12.

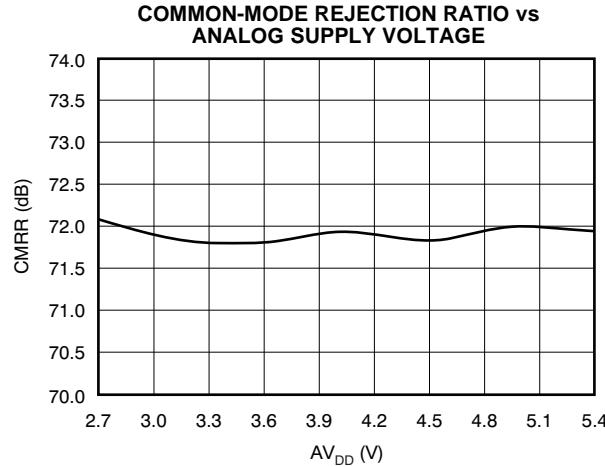


Figure 13.

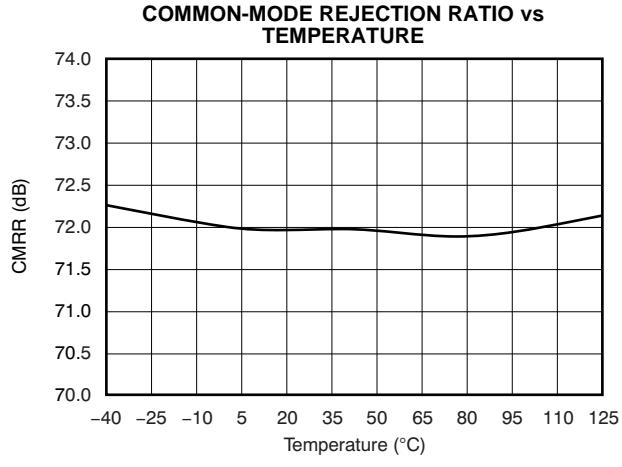


Figure 14.

TYPICAL CHARACTERISTICS (continued)

Over the entire supply voltage range; $V_{REF} = 2.5V$ (internal), $f_{CLK} = 32MHz$, and $f_{DATA} = 2MSPS$, unless otherwise noted.

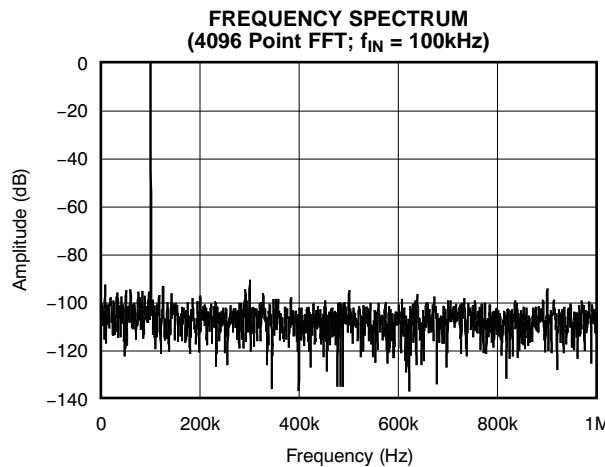


Figure 15.

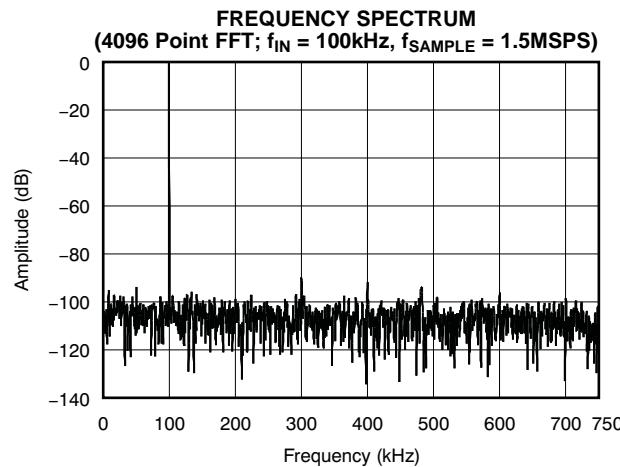


Figure 16.

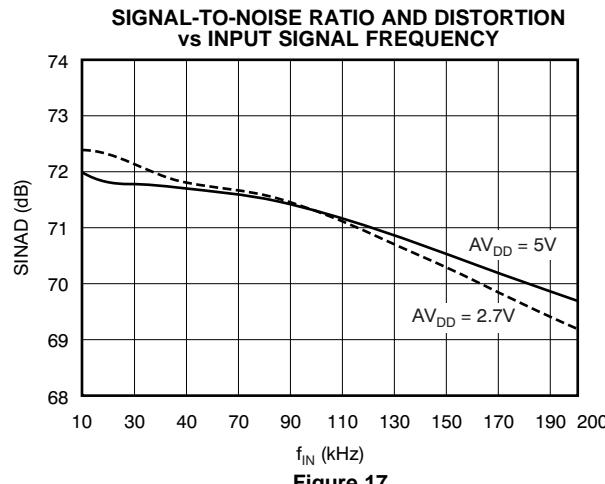


Figure 17.

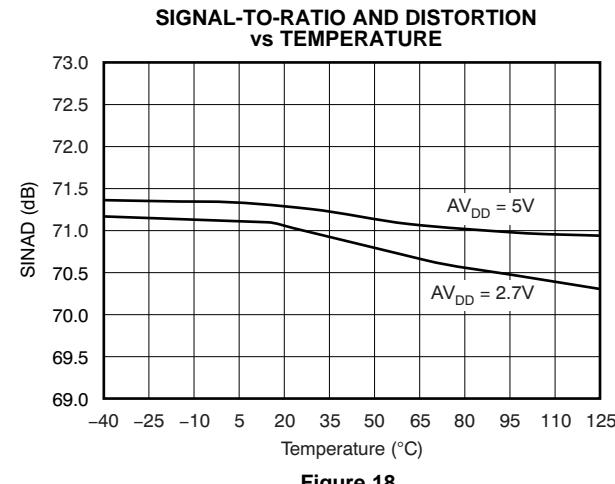


Figure 18.

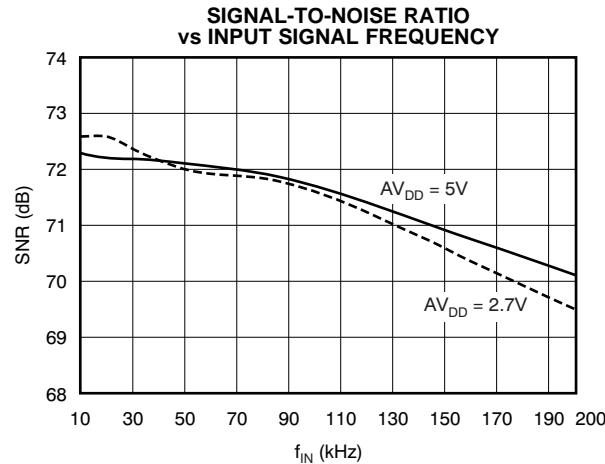


Figure 19.

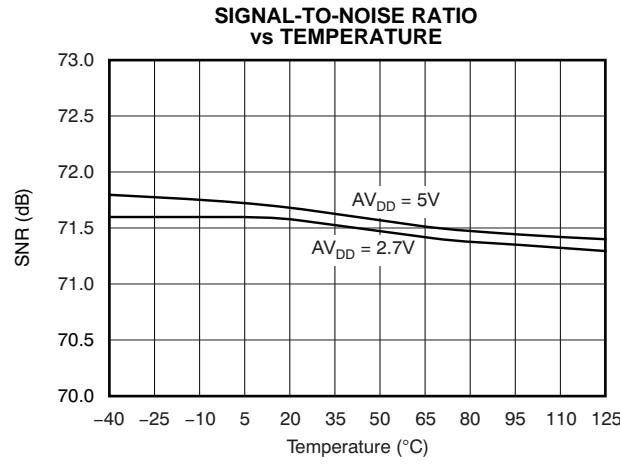


Figure 20.

TYPICAL CHARACTERISTICS (continued)

Over the entire supply voltage range; $V_{REF} = 2.5V$ (internal), $f_{CLK} = 32MHz$, and $f_{DATA} = 2MSPS$, unless otherwise noted.

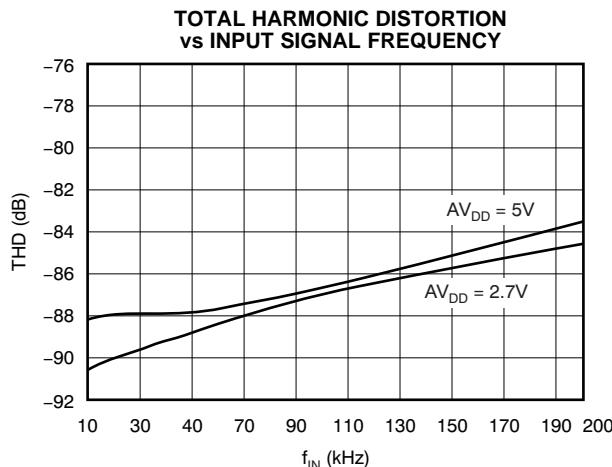


Figure 21.

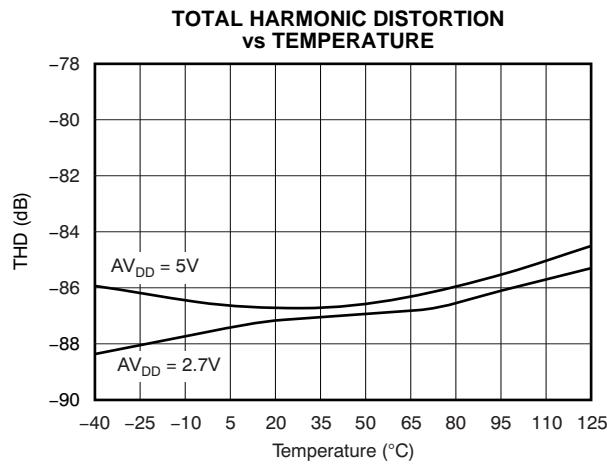


Figure 22.

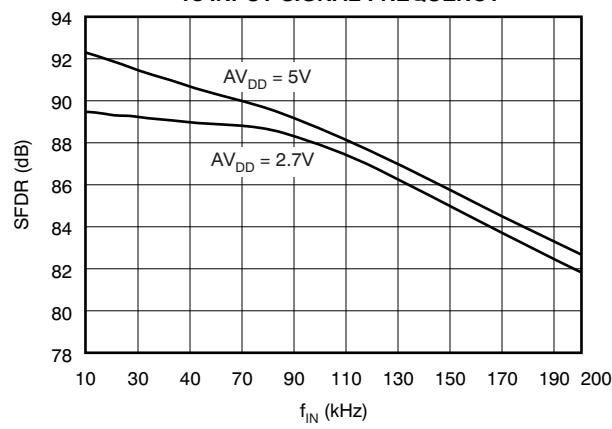


Figure 23.

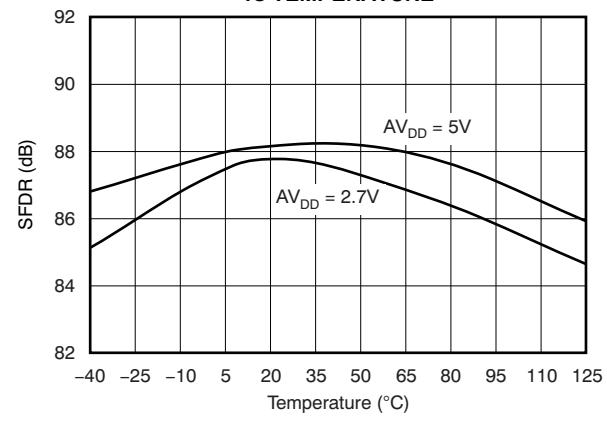


Figure 24.

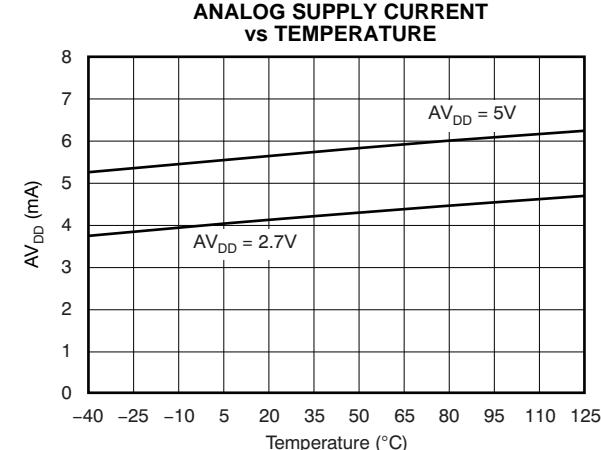


Figure 25.

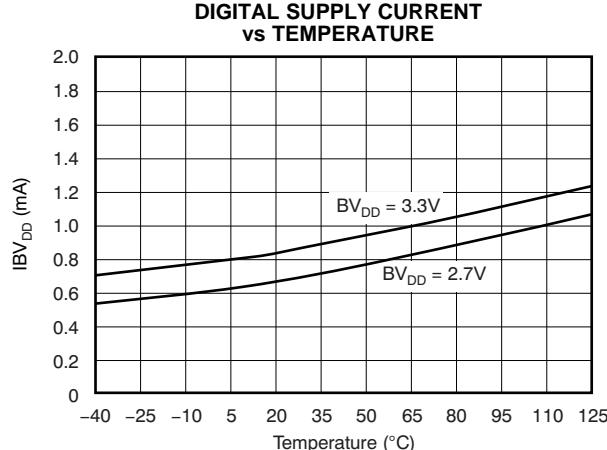


Figure 26.

TYPICAL CHARACTERISTICS (continued)

Over the entire supply voltage range; $V_{REF} = 2.5V$ (internal), $f_{CLK} = 32MHz$, and $f_{DATA} = 2MSPS$, unless otherwise noted.

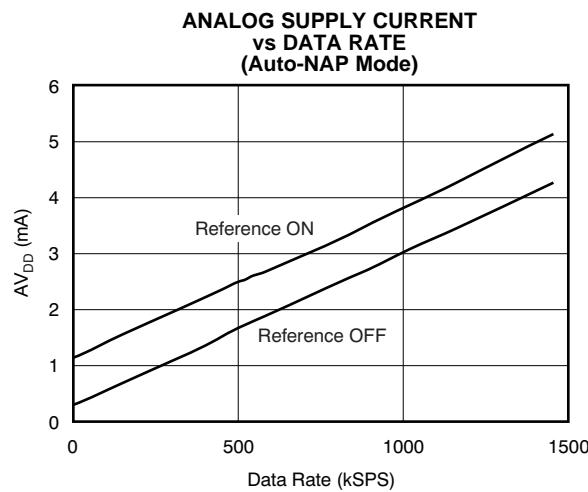


Figure 27.

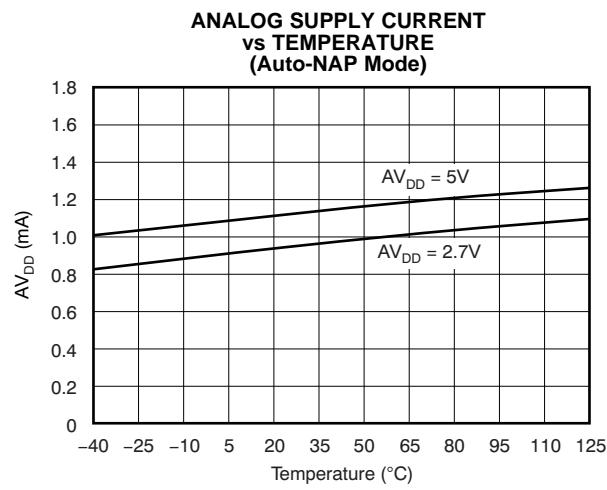


Figure 28.

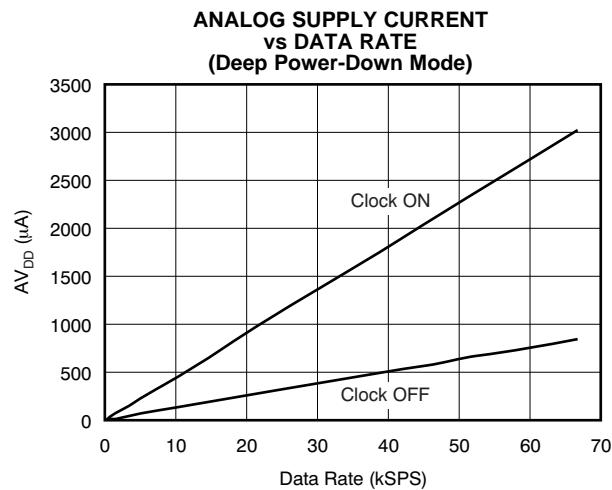


Figure 29.

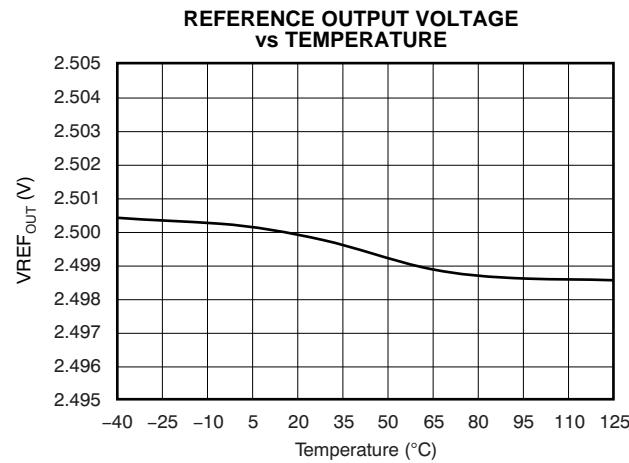


Figure 30.

APPLICATION INFORMATION

GENERAL DESCRIPTION

The ADS7865 includes two 12-bit analog-to-digital converters (ADCs) that operate based on the successive-approximation register (SAR) principle. The ADCs sample and convert simultaneously. Conversion time can be as low as 406.25ns. Adding the acquisition time of 62.5ns and an additional clock cycle for setup/hold time requirements and skew results in a maximum conversion rate of 2MSPS.

Each ADC has a fully differential 2:1 multiplexer front-end. In many common applications, all negative input signals remain at the same constant voltage (for example, 2.5V). In this type of application, the multiplexer can be used in a pseudo-differential 3:1 mode, where CHx0– functions as a common-mode input and the remaining three inputs (CHx0+, CHx1–, and CHx1+) operate as separate inputs referred to the common-mode input.

The ADS7865 also includes a 2.5V internal reference. The reference drives a 10-bit digital-to-analog converter (DAC), allowing the voltage at the REF_{OUT} pin to be adjusted via the internal DAC register in 2.44mV steps. A low-noise operational amplifier with unity-gain buffers the DAC output voltage and drives the REF_{OUT} pin.

The ADS7865 offers a parallel interface that is pin-compatible with the ADS7862. However, instead of the A0 pin of the ADS7862 that controls channel selection, the ADS7865 offers a write data input (WR) pin that supports additional functions described in the *Digital* section of this data sheet (see also the *ADS7862 Compatibility* section).

ANALOG

This section discusses the analog input circuit, the ADCs, and the reference design of the device.

Analog Inputs

Each ADC is fed by an input multiplexer, as shown in [Figure 31](#). Each multiplexer is either used in a fully-differential 2:1 configuration (as described in [Table 1](#)) or a pseudo-differential 3:1 configuration (as shown in [Table 2](#)). The channel selection is performed using bits C1 and C0 in the configuration register (see also the *Configuration Register* section).

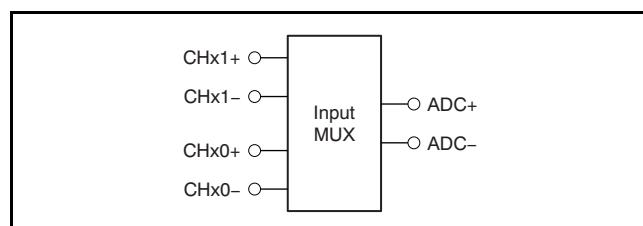


Figure 31. Input Multiplexer Configuration

Table 1. Fully Differential 2:1 Multiplexer Configuration

| C1 | C0 | ADC+ | ADC- |
|----|----|-------|-------|
| 0 | 0 | CHx0+ | CHx0– |
| 1 | 1 | CHx1+ | CHx1– |

Table 2. Pseudo-Differential 3:1 Multiplexer Configuration

| C1 | C0 | ADC+ | ADC- |
|----|----|-------|-------|
| 0 | 0 | CHx0+ | CHx0– |
| 0 | 1 | CHx1– | CHx0– |
| 1 | 0 | CHx1+ | CHx0– |

The input path for the converter is fully differential and provides a common-mode rejection of 72dB at 100kHz. The high CMRR also helps suppress noise in harsh industrial environments.

Each of the 2pF sample-and-hold capacitors (shown as C_S in the *Equivalent Input Circuit*) is connected via switches to the multiplexer output. Opening the switches holds the sampled data during the conversion process. After finishing the conversion, both capacitors are pre-charged for the duration of one clock cycle to the voltage present at the REF_{IN} pin. After the pre-charging, the multiplexer outputs are connected to the sampling capacitors again. The voltage at the analog input pin is usually different from the reference voltage; therefore, the sample capacitors must be charged to within one-half LSB for 12-bit accuracy during the acquisition time t_{ACQ} (see the *Timing Characteristics*).

Acquisition time is indicated with the BUSY signal being held low. It starts by closing the input switches (after finishing the previous conversion and pre-charging) and finishes with the rising edge of the CONVST signal. If the ADS7865 operates at full speed, the acquisition time is typically 62.5ns.

The minimum -3dB bandwidth of the driving operational amplifier can be calculated as shown in [Equation 1](#), with $n = 12$ being the resolution of the ADS7865:

$$f_{-3\text{dB}} = \frac{\ln(2) \times (n + 1)}{2\pi \times t_{\text{ACQ}}} \quad (1)$$

With $t_{\text{ACQ}} = 62.5\text{ns}$, the minimum bandwidth of the driving amplifier is 23MHz. The required bandwidth can be lower if the application allows a longer acquisition time.

A gain error occurs if a given application does not fulfill the settling requirement shown in [Equation 1](#). As a result of pre-charging the capacitors, linearity and THD are not directly affected, however.

The [OPA365](#) from Texas Instruments is recommended as a driver; in addition to offering the required bandwidth, it provides a low offset and also offers excellent THD performance.

The phase margin of the driving operational amplifier is usually reduced by the ADC sampling capacitor. A resistor placed between the capacitor and the amplifier limits this effect; therefore, an internal 200Ω resistor (R_{SER}) is placed in series with the switch. The switch resistance (R_{SW}) is typically 50Ω (see the [Equivalent Input Circuit](#)).

The differential input voltage range of the ADC is $\pm V_{\text{REF}}$, the voltage at the REF_{IN} pin.

It is important to keep the voltage to all inputs within the 0.1V limit below AGND and above AV_{DD} while not allowing dc current to flow through the inputs. Current is only necessary to recharge the sample-and-hold capacitors.

Analog-to-Digital Converter (ADC)

The ADS7865 includes two SAR-type, 2MSPS, 12-bit ADCs (shown in the [Functional Block Diagram](#) on the front page of this data sheet).

CONVST

The analog inputs are held with the falling edge of the **CONVST** (conversion start) signal. The setup time of **CONVST** referred to the next rising edge of **CLOCK** (system clock) is 10ns (minimum). The conversion automatically starts with the rising **CLOCK** edge. **CONVST** should not be issued during a conversion, that is, when **BUSY** is high.

CLOCK

The ADC uses an external clock in the range of 1MHz to 32MHz. 12 clock cycles are needed for a complete conversion; the following clock cycle is used for pre-charging the sample capacitors and a minimum of two clock cycles are required for the sampling. With a minimum of 16 clocks used for the entire process, one clock cycle is left for the required setup and hold times along with some margin for delay caused by layout. The clock input can remain low between conversions (after applying the 16th falling edge to complete a running conversion). It can also remain low after applying the 14th falling edge during a DAC register write access if the device is not required to perform a conversion (for example, during an initiation phase after power-up).

The **CLOCK** duty cycle should be 50%. However, the ADS7865 functions properly with a duty cycle between 30% and 70%.

RESET

The ADS7865 features an internal power-on-reset (POR) function. When the device is powered up, the POR sets the device to default mode when AVDD reaches 1.5V. When the device is powered down, the POR circuit requires AVDD to remain below 125mV for at least 350ms to ensure proper discharging of internal capacitors and to correct the behavior of the ADS7865 when powered up again. If AVDD drops below 400mV but remains above 125mV, the internal POR capacitor does not discharge fully and the ADS7865 requires a software reset to perform correctly after the recovery of AVDD (this condition is shown as the *undefined zone* in [Figure 32](#)). A software reset can be issued using configuration register bits A[2:0] (see the [Digital](#) section).

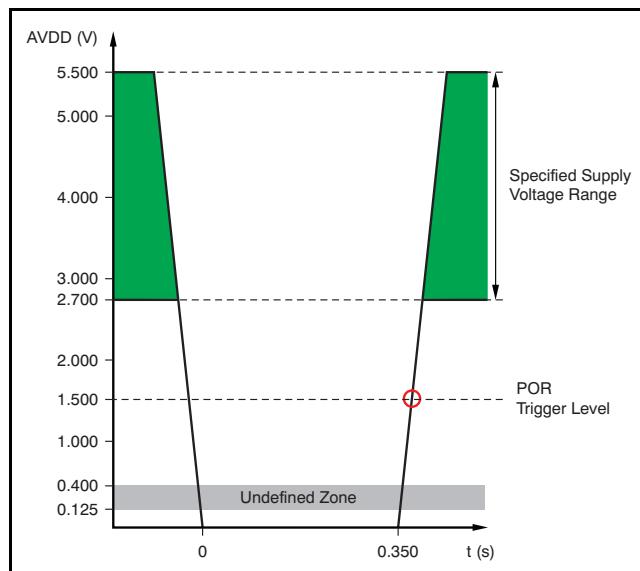


Figure 32. Relevant Voltage Levels for POR

REF_{IN}

The reference input is not buffered and is directly connected to the ADC. The converter generates spikes on the reference input voltage because of internal switching. Therefore, an external capacitor to the analog ground (AGND) should be used to stabilize the reference input voltage. This capacitor should be at least 470nF. Ceramic capacitors (X5R type) with values up to 1 μ F are commonly available as SMD in 0402 size.

REF_{OUT}

The ADS7865 includes a low-drift, 2.5V internal reference source. This source feeds a 10-bit string DAC that is controlled via the DAC register. As a result of this architecture, the voltage at the REF_{OUT} pin is programmable in 2.44mV steps and can be adjusted to specific application requirements without the use of additional external components.

However, the DAC output voltage should not be programmed below 0.5V to ensure the correct functionality of the reference output buffer. This buffer is connected between the DAC and the REF_{OUT} pin, and is capable of driving the capacitor at the REF_{IN} pin. A minimum of 470nF is required to keep the reference stable (see the previous discussion of REF_{IN}). For applications that use an external reference source, the internal reference can be disabled using bit RP in the SDI Register (see the [Digital](#) section). The settling time of the REF_{OUT} pin is 500 μ s (max) with the reference capacitor connected. The default value of the REF_{OUT} pin after power-up is 2.5V.

For operation with a 2.7V analog supply and a 2.5V reference, the internal reference buffer requires a rail-to-rail input and output. Such buffers typically contain two input stages; when the input voltage passes the mid-range area, a transition occurs at the output because of switching between the two input stages. In this voltage range, rail-to-rail amplifiers generally show a very poor power-supply rejection.

As a result of this poor performance, the ADS7865 buffer has a fixed transition at DAC code 509 (0x1FD). At this code, the DAC may show a jump of up to 10mV in its transfer function.

[Table 3](#) lists some examples of internal reference DAC settings.

Table 3. Reference DAC Setting Examples

| V _{REFOUT} | DECIMAL CODE | BINARY CODE | HEXADECIMAL CODE |
|---------------------|--------------|--------------|------------------|
| 0.500V | 205 | 00 1100 1101 | CD |
| 1.241V | 508 | 01 1111 1100 | 1FC |
| 1.240V | 509 | 01 1111 1101 | 1FD |
| 2.500V | 1023 | 11 1111 1111 | 3FF |

DIGITAL

This section reviews the timing and control of the ADS7865 parallel interface.

Configuration Register

The configuration register can be set by issuing a write access on the parallel interface. The data present on DB[11:0] are latched with the rising edge of WR. The data word width of the configuration register is 12 bits; its structure is shown in [Table 4](#). The default value of this register after power-up is 0x000.

Table 4. Configuration Register Map

| CONFIGURATION REGISTER BIT | | | | | | | | | | | |
|----------------------------|----|----|----|----|---|----|----|------------------|----|----|----|
| 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| C1 | C0 | R1 | R0 | DP | N | AN | RP | X ⁽¹⁾ | A2 | A1 | A0 |

(1) X = Don't care.

Table 5. C1 and C0: Channel Selection

| C1 | C0 | ADC A/B | |
|----|----|----------------|----------------|
| | | POSITIVE INPUT | NEGATIVE INPUT |
| 0 | 0 | CHA0+/CHB0+ | CHA0-/CHB0- |
| 0 | 1 | CHA1-/CHB1- | CHA0-/CHB0- |
| 1 | 0 | CHA1+/CHB1+ | CHA0-/CHB0- |
| 1 | 1 | CHA1+/CHB1+ | CHA1-/CHB1- |

Table 6. R1 and R0: Register Update Enable

| R1 | R0 | FUNCTION |
|----|----|---------------------------------------|
| 0 | 0 | Register update disabled |
| 0 | 1 | Register update enabled |
| 1 | 0 | Reserved for factory test (don't use) |
| 1 | 1 | Register update disabled |

DP: Deep power-down enable

('1' = device in deep power-down mode)

N: Nap power-down enable

('1' = device in nap power-down mode)

AN: AutoNap power-down enable

('1' = device in autonap power-down mode)

RP: Reference power-down

('1' = reference is turned off)

Table 7. A2, A1, and A0: DAC, Sequencer, and SW-Reset Control

| A2 | A1 | A0 | FUNCTION |
|----|----|----|---|
| 0 | 0 | 0 | Configuration register update only |
| 0 | 0 | 1 | Write to reference DAC register with next access |
| 0 | 1 | 0 | Configuration register update only |
| 0 | 1 | 1 | Read from reference DAC register with next access |
| 1 | 0 | 0 | Write to sequencer register |
| 1 | 0 | 1 | Device SW-reset |
| 1 | 1 | 0 | Read from sequencer register |
| 1 | 1 | 1 | Configuration register update only |

All enabled power-down features are activated by the rising edge of the WR pulse immediately after writing to the configuration register.

Because two write accesses are required to program the reference DAC and the sequencer registers, these settings are updated with the rising edge of WR after the second write access. For more details, see the [Sequencer Register](#) and [Programming the Reference DAC](#) sections.

Figure 33 shows a complete timing diagram consisting of a write access to set up the proper input channel, followed by an initiation of a conversion and the read access of both conversion results.

The input multiplexer updates with the rising edge of the WR input. The following falling edge of CONVST triggers the conversion of the previously selected channel. The data output register then updates with the falling edge of BUSY and can be read thereafter. The digital output code format of the ADS7865 is in binary two's complement, as shown in Table 8.

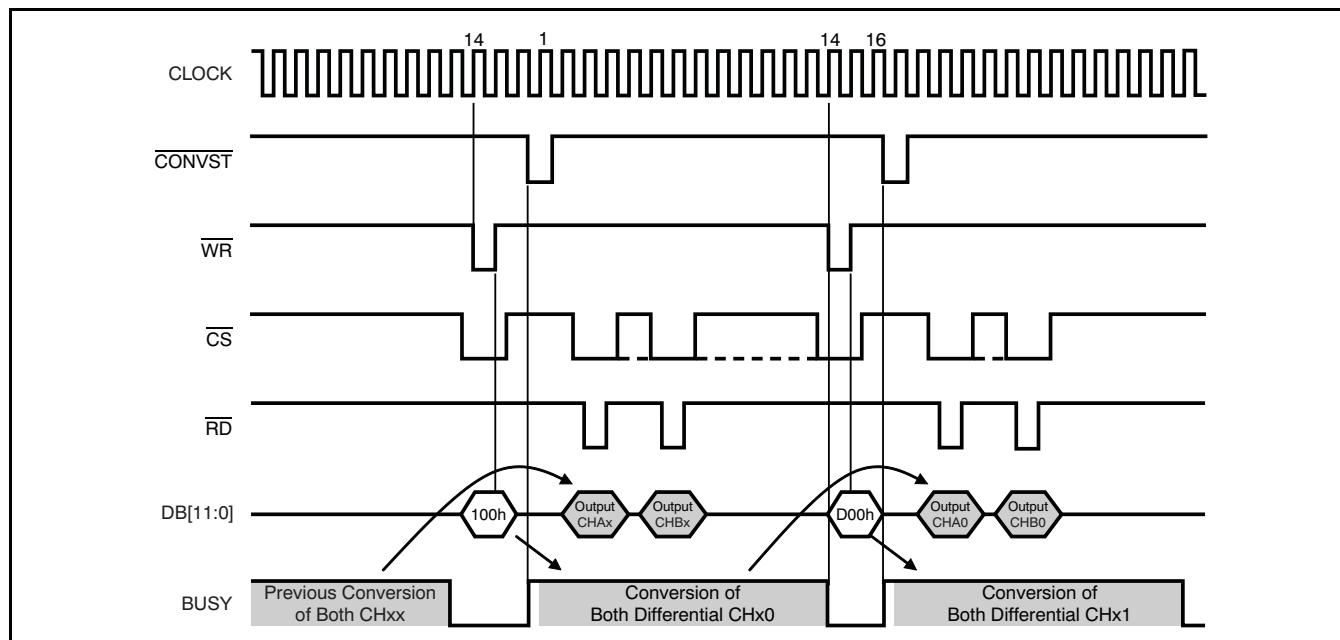


Figure 33. Channel Selection Timing Diagram

Table 8. ADS7865 Output Data Format

| DESCRIPTION | DIFFERENTIAL INPUT VOLTAGE (CHXX+) – (CHXX–) | INPUT VOLTAGE AT CHXX+ (CHXX– = V _{REF} = 2.5V) | BINARY CODE | HEXADECIMAL CODE |
|---------------------|--|--|----------------|------------------|
| Positive full-scale | V _{REF} | 5V | 0111 1111 1111 | 7FF |
| Midscale | 0V | 2.5V | 0000 0000 0000 | 000 |
| Midscale – 1LSB | –V _{REF} /4096 | 2.49878V | 1111 1111 1111 | FFF |
| Negative full-scale | –V _{REF} | 0V | 1000 0000 0000 | 800 |

Sequencer Register

The ADS7865 features a programmable sequencer that controls the switching of the ADC input multiplexer. To set up the sequencer, two write accesses to the ADC are required. During the first write access, the programming of the sequencer must be enabled by setting R[1:0] = '01' and A[2:0] = '100' in the configuration register. The data applied to the data bus on the second write access contain the updated sequencer register content.

The structure of the sequencer register is shown in [Table 9](#). The default value of this register after power-up is 0x000.

Detailed timing diagrams of the different sequencer modes are shown in [Figure 34](#).

[Figure 35](#) shows an example where the sequencer is set to scan through the pseudo-differential inputs of the ADS7865 beginning with CHx1+, followed by CHx1–, and CHx0+ while using a single CONVST and BUSY for the entire sequence.

Table 9. Sequencer Register Map

| SEQUENCER REGISTER BIT | | | | | | | | | | | | |
|------------------------|----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|--|
| 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | |
| S1 | S0 | SL1 | SL0 | CH1 | CM1 | CH2 | CM2 | CH3 | CM3 | SP1 | SP0 | |

Table 10. S1 and S0: Sequencer Mode

| S1 | S0 | FUNCTION |
|----|----|---|
| 0 | X | Individual <u>CONVST</u> and <u>BUSY</u> for each conversion |
| 1 | 0 | Single <u>CONVST</u> for entire sequence and individual <u>BUSY</u> for each conversion |
| 1 | 1 | Single <u>CONVST</u> and <u>BUSY</u> for entire sequence |

Table 11. SL1 and SL0: Sequence Length

| SL1 | SL0 | FUNCTION |
|-----|-----|--|
| 0 | 0 | Length = 0: Sequencer disabled |
| 0 | 1 | Length = 1: Cx1 (bits 6/7) enabled |
| 1 | 0 | Length = 2: Cx1 (bits 6/7) and Cx2 (bits 4/5) enabled |
| 1 | 1 | Length = 3: Cx1 (bits 6/7), Cx2 (bits 4/5), and Cx3 (bits 2/3) enabled |

CH1: Signal input of the first channel in sequence; refer to [Table 12](#) for details.

CM1: Common-mode input of the first channel in sequence; refer to [Table 12](#) for details.

CH2: Signal input of the second channel in sequence; refer to [Table 12](#) for details.

CM2: Common-mode input of the second channel in sequence; refer to [Table 12](#) for details.

CH3: Signal input of the third channel in sequence; refer to [Table 12](#) for details.

CM3: Common-mode input of the third channel in sequence; refer to [Table 12](#) for details.

Table 12. Channel Selection

| CHx | CMx | ADC A/B | |
|-----|-----|--------------|-------------------|
| | | SIGNAL INPUT | COMMON-MODE INPUT |
| 0 | 0 | CHA0+/CHB0+ | CHA0-/CHB0- |
| 0 | 1 | CHA1-/CHB1- | CHA0-/CHB0- |
| 1 | 0 | CHA1+/CHB1+ | CHA0-/CHB0- |
| 1 | 1 | CHA1+/CHB1+ | CHA1-/CHB1- |

Table 13. SP1 and SP0: Sequence Position (Read-Only)

| SP1 | SP0 | FUNCTION |
|-----|-----|--|
| 0 | 0 | Sequencer disabled |
| 0 | 1 | CH1/CM1 (bits 6/7) to be converted at next falling edge of <u>CONVST</u> |
| 1 | 0 | CH2/CM2 (bits 4/5) to be converted at next falling edge of <u>CONVST</u> |
| 1 | 1 | CH3/CM3 (bits 2/3) to be converted at next falling edge of <u>CONVST</u> |

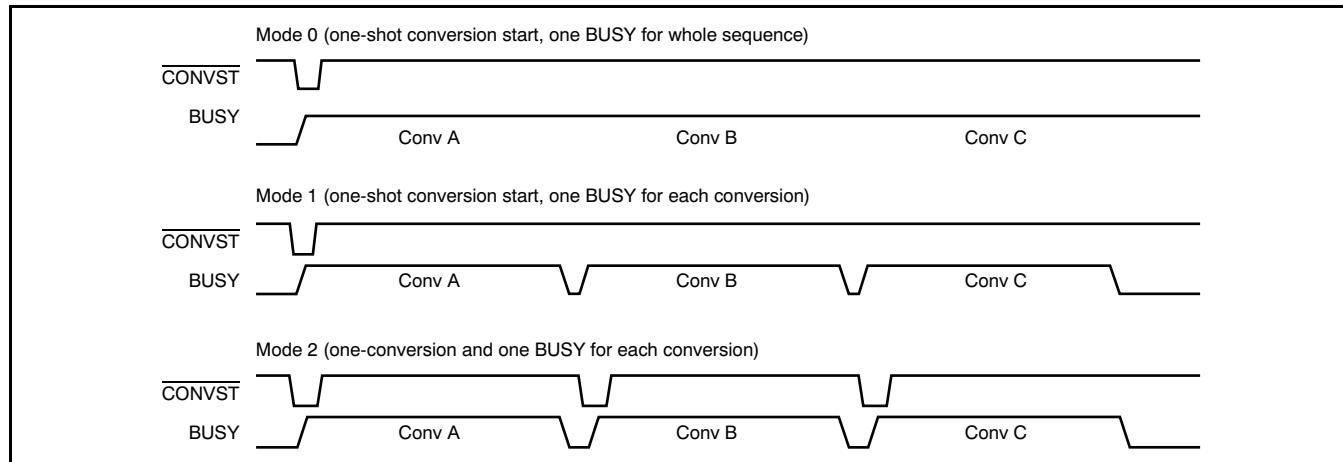


Figure 34. Sequencer Modes (Example: SL = '11')

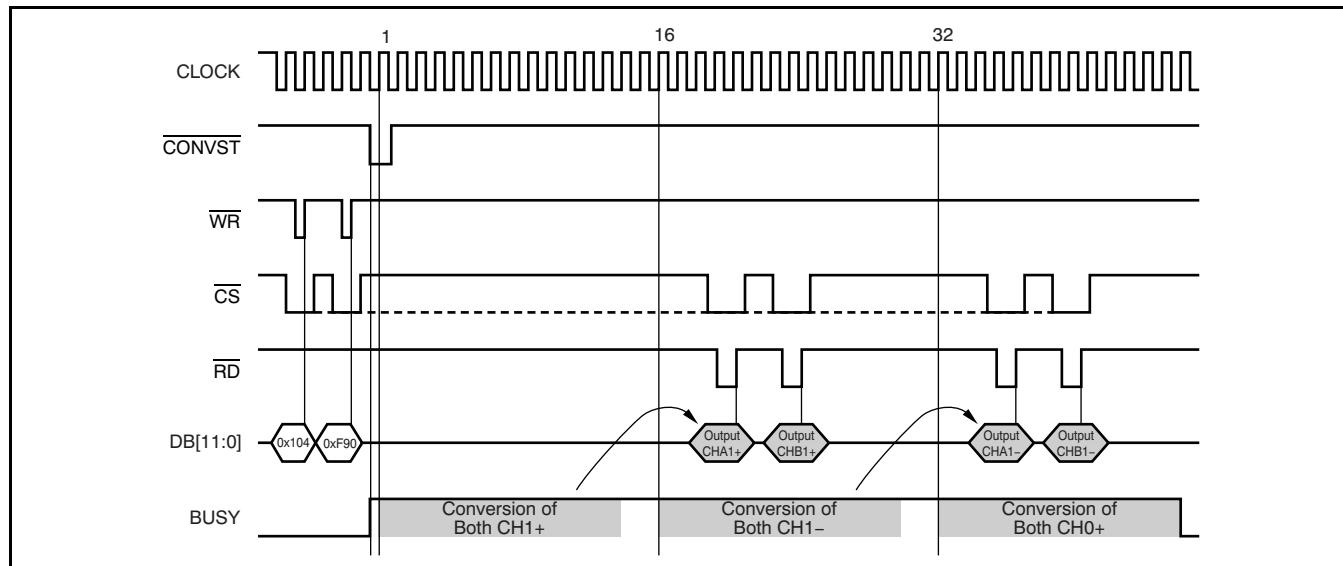


Figure 35. Sequencer Programming Example

Programming the Reference DAC

The internal reference DAC can be set by issuing a \overline{WR} pulse while providing a control word with $R[1:0] = '01'$ and $A[2:0] = '001'$ (see [Table 4](#)). Thereafter, a second \overline{WR} pulse must be generated with the data bus bits $DB[11:10] = '00'$ and $DB[9:0]$ containing the actual 10-bit DAC value, with $DB9$ being the MSB (see [Figure 36](#)).

To verify the current DAC setting, a \overline{WR} pulse must

be generated while providing a control word containing $R[1:0] = '01'$ and $A[2:0] = '011'$ to initialize the DAC read access. Thereafter, triggering the \overline{RD} line causes the data bus to provide the 10-bit DAC value on $DB[9:0]$.

[Table 14](#) shows the content of this register; the default value after power-up is 0x3FF (see also [Table 3](#)).

Table 14. DAC Register Contents

| DAC REGISTER CONTENT | | | | | | | | | | | | |
|----------------------|----|-----|-------|-------|-------|-------|-------|-------|-------|-------|-------|--|
| 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | |
| 0 | 0 | MSB | Bit 8 | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 | |

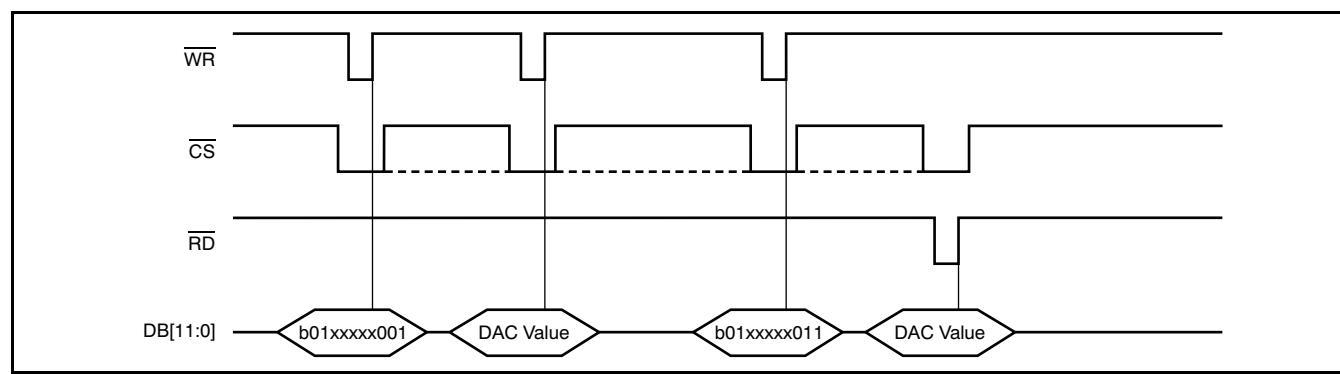


Figure 36. DAC Write and Read Access Timing Diagram

Power-Down Modes and Reset

The ADS7865 has a comprehensive built-in power-down feature. There are three power-down modes: deep power-down, nap power-down, and auto-nap power-down. All three power-down modes are activated with the rising \overline{WR} edge after having been activated by asserting the corresponding bit in the Configuration Register ($DP = '1'$, $N = '1'$, or $AN = '1'$). All modes are deactivated by de-asserting the respective bit in the Configuration Register. The contents of the Configuration Register are not affected by any of the power-down modes. Any ongoing conversion aborts when deep or nap power-down is initiated. **Table 15** lists the differences among the three power-down modes.

In **deep power-down mode**, all functional blocks except the digital interface are disabled. The analog block has its bias currents turned off. In this mode, the power dissipation reduces to $1\mu A$ within $2\mu s$. The wake-up time from deep power-down mode is $1\mu s$.

In **nap power-down mode**, the ADS7865 turns off the biasing of the comparator and the mid-voltage buffer within 200ns. The device goes into nap power-down mode regardless of the conversion state.

The **auto-nap power-down mode** is very similar to the nap mode. The only differences are the methods of powering down and waking up the device. The Configuration Register bit AN is only used to enable/disable this feature. If the auto-nap mode is enabled, the ADS7865 turns off the biasing automatically after finishing a conversion; thus, the end of conversion actually activates the auto-nap power-down. The device powers down within 200ns in this mode, as well. Triggering a new conversion by applying a \overline{CONVST} pulse returns the device to normal operation and automatically starts a new conversion six CLOCK cycles later. Therefore, a complete conversion cycle takes 22 CLOCK cycles; thus, the maximum throughput rate in auto-nap power-down mode is reduced to 1.45MSPS.

To issue a **device reset**, a write access to the Configuration Register must be generated to set $A[2:0] = '101'$. With the rising edge of the \overline{WR} input, the entire device is forced into reset. After approximately 20ns, the parallel interface becomes active again.

Table 15. Power-Down Modes

| POWER-DOWN TYPE | ENABLED BY | ACTIVATED BY | ACTIVATION TIME | RESUMED BY | REACTIVATION TIME | DISABLED BY |
|-----------------|------------|-----------------------------|-----------------|---------------------------|-------------------|-------------|
| Deep | $DP = '1'$ | Rising \overline{WR} edge | $2\mu s$ | $DP = '0'$ | $1\mu s$ | $DP = '0'$ |
| Nap | $N = '1'$ | Rising \overline{WR} edge | 200ns | $N = '0'$ | 6 clocks | $N = '0'$ |
| Auto-nap | $AN = '1'$ | Each end of conversion | 200ns | \overline{CONVST} pulse | 6 clocks | $AN = '0'$ |

ADS7862 COMPATIBILITY

The ADS7865IPBS is pin-compatible with the ADS7862Y. However, there are some differences between the two devices that must be considered when migrating from the ADS7862 to the ADS7865 in an existing design.

WR versus A0

One of the differences is that pin 22, which triggers writing to the internal Configuration Register of the ADS7865 (WR), is used to select the input channel on the ADS7862 (A0).

Channel selection on the ADS7865 can only be performed by setting bits C[1:0] in the Configuration Register or, automatically, by the sequencer (see the *Sequencer Register* section for details).

REF_{IN}

The ADS7865 offers an unbuffered REF_{IN} input with a code-dependent input impedance while featuring a programmable and buffered reference output (REF_{OUT}). The ADS7862 offers a high-impedance (buffered) reference input. If an existing ADS7862-based design uses the internal reference of the device and relies on an external resistor divider to adjust the input voltage range of the ADC, migration to the ADS7865 platform requires one of the following conditions:

- A software change to set up the internal reference DAC properly via the DAC register while removing the external resistors; **or**

- An additional external buffer between the resistor divider and the required 470nF (minimum) capacitor on the REF_{IN} input.

In the latter case, while the capacitor stabilizes the reference voltage during the entire conversion, the buffer must recharge it by providing an average current only; thus, the required minimum bandwidth of the buffer can be calculated using [Equation 2](#):

$$f_{-3dB} = \frac{\ln(2) \times 2}{2\pi \times 16 \times t_{CLK}} \quad (2)$$

The buffer must also be capable of driving the 470nF load while maintaining its stability.

Timing

The only timing requirement that may cause the ADS7865 to malfunction in an existing ADS7862-based design is the CONVST low time (t₁) which is specified to be 20ns minimum, while the ADS7862 works properly with a pulse as short as 15ns. All other required minimum setup and hold times are specified to be either the same as or lower than the ADS7865; therefore, there are no conflicts with the ADS7862 requirements.

APPLICATION INFORMATION

The absolute minimum configuration of the ADS7865 in an application is shown in [Figure 37](#). In this case, the ADS7865 is used in dual-channel mode only, with the default settings of the device after power up.

The input signal for the amplifiers must fulfill the common-mode voltage requirements of the ADS7865 in this configuration. The actual values of the resistors and capacitors depend on the bandwidth and performance requirements of the application.

Those values can be calculated using [Equation 3](#), with $n = 12$ being the resolution of the ADS7865.

$$f_{\text{FILTER}} = \frac{\ln(2) \times (n + 1)}{2 \times \pi \times 2 \times R \times C} \quad (3)$$

It is recommended to use a capacitor value of at least 20pF.

Keep the acquisition time in mind; the resistor value can be calculated as shown in [Equation 4](#) for each of the series resistors (with $n = 12$, the resolution of the ADS7865).

$$R = \frac{t_{ACQ}}{\ln(2) \times (n + 1) \times 2 \times C} \quad (4)$$

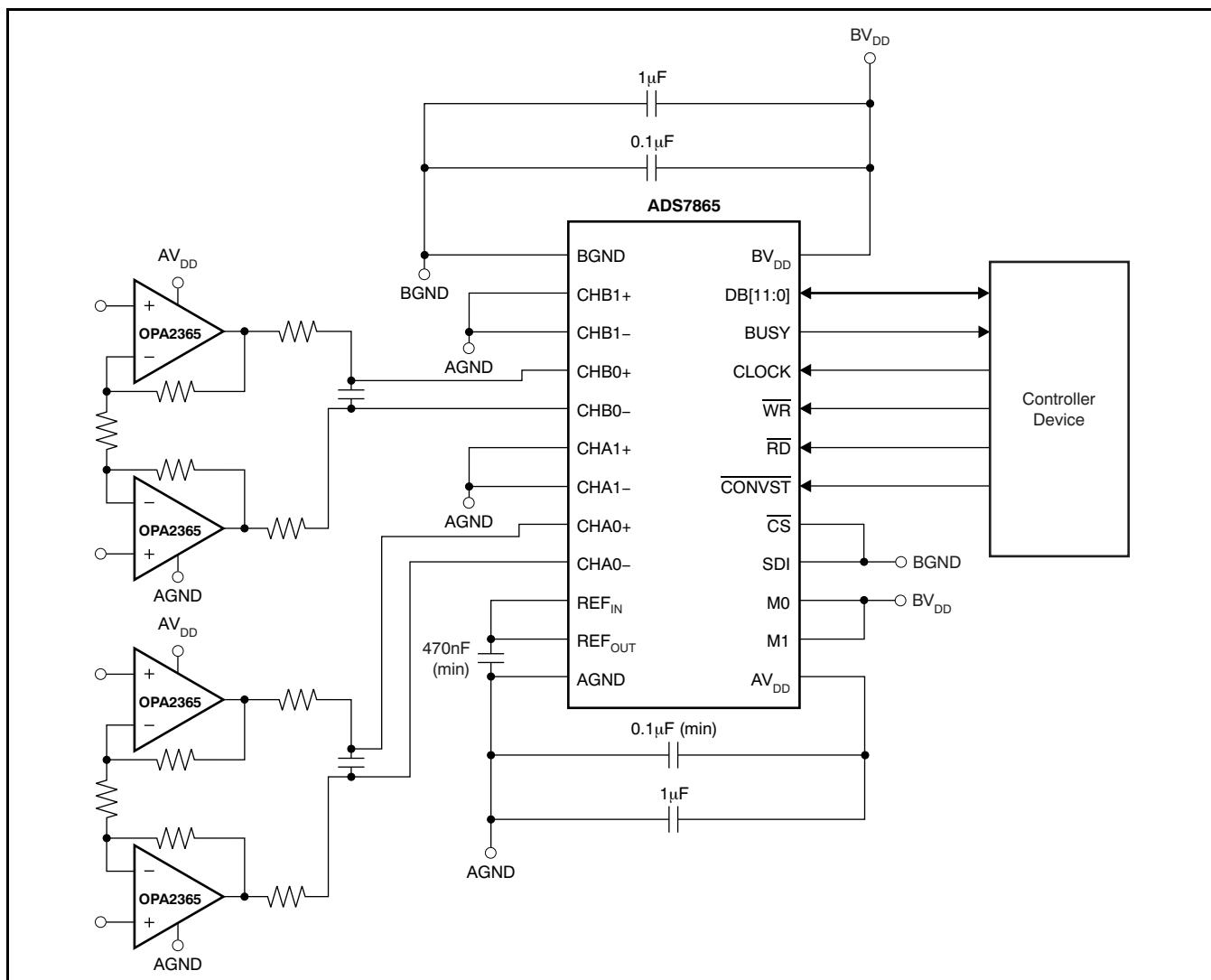


Figure 37. Minimum ADS7865 Configuration

LAYOUT

For optimum performance, care should be taken with the physical layout of the ADS7865 circuitry. This caution is particularly true if the CLOCK input approaches the maximum throughput rate. In this case, it is recommended to have a fixed phase relationship between CLOCK and CONVST.

Additionally, the basic SAR architecture is quite sensitive to glitches or sudden changes on the power supply, reference, ground connections, and digital inputs that occur just before latching the output of the analog comparator. Therefore, when driving any single conversion for an n -bit SAR converter, there are n windows in which large external transient voltages can affect the conversion result. Such glitches might originate from switching power supplies, nearby digital logic, or high-power devices. The degree of error in the digital output depends on the reference voltage, layout, and the exact timing of the external event. These errors can change if the external event also changes in time with respect to the CLOCK input.

With this possibility in mind, power to the ADS7865 should be clean and well-bypassed. A $0.1\mu\text{F}$ ceramic bypass capacitor should be placed as close to the device as possible. In addition, a $1\mu\text{F}$ to $10\mu\text{F}$ capacitor is recommended. If needed, an even larger capacitor and a 5Ω or 10Ω series resistor may be used to low-pass filter a noisy supply.

If the reference voltage is external and originates from an operational amplifier, be sure that it can drive the reference capacitor without oscillation. The connection between the output of the external reference driver and REF_{IN} should be of low resistance (10Ω max) to minimize any code-dependent voltage drop on this path.

Grounding

All ground (AGND and BGND) pins should be connected to a clean ground reference. These connections should be kept as short as possible to minimize the inductance of these paths. It is recommended to use vias connecting the pads directly to the ground plane. In designs without ground planes, the ground trace should be kept as wide as possible. Avoid connections that are too near the grounding point of a microcontroller or digital signal processor.

Depending on the circuit density of the board, placement of the analog and digital components, and the related current loops, a single solid ground plane for the entire printed circuit board (PCB) or a dedicated analog ground area may be used. In an

instance of a separated analog ground area, ensure a low-impedance connection between the analog and digital ground of the ADC by placing a bridge underneath (or next to) the ADC. Otherwise, even short undershoots on the digital interface with a value lower than -300mV may lead to conduction of ESD diodes, causing current flow through the substrate and degrading the analog performance.

During the PCB layout process, care should also be taken to avoid any return currents crossing any sensitive analog areas or signals. No signal must exceed the limit of -300mV with regard to the respective ground plane. [Figure 38](#) illustrates the recommended layout of the ground and power-supply connections.

Supply

The ADS7865 has two separate supplies: the BV_{DD} pin for the digital interface and the AV_{DD} pin for all remaining circuits.

BV_{DD} can range from 2.7V to 5.5V, allowing the ADS7865 to easily interface with processors and controllers. To limit the injection of noise energy from external digital circuitry, BV_{DD} should be filtered properly. Bypass capacitors of $0.1\mu\text{F}$ and $10\mu\text{F}$ should be placed between the BV_{DD} pin and the ground plane.

AV_{DD} supplies the internal analog circuitry. For optimum performance, a linear regulator (for example, the [UA7805](#) family) is recommended to generate the analog supply voltage in the range of 2.7V to 5.5V for the ADS7865 and the necessary analog front-end circuitry.

Bypass capacitors should be connected to the ground plane such that the current is allowed to flow through the pad of the capacitor (that is, the vias should be placed on the opposite side of the connection between the capacitor and the power-supply pin of the ADC).

Digital Interface

To further optimize device performance, a series resistor of 10Ω to 100Ω can be used on each digital pin of the ADS7865. In this way, the slew rates of the input and output signals are reduced, limiting the noise injection from the digital interface.

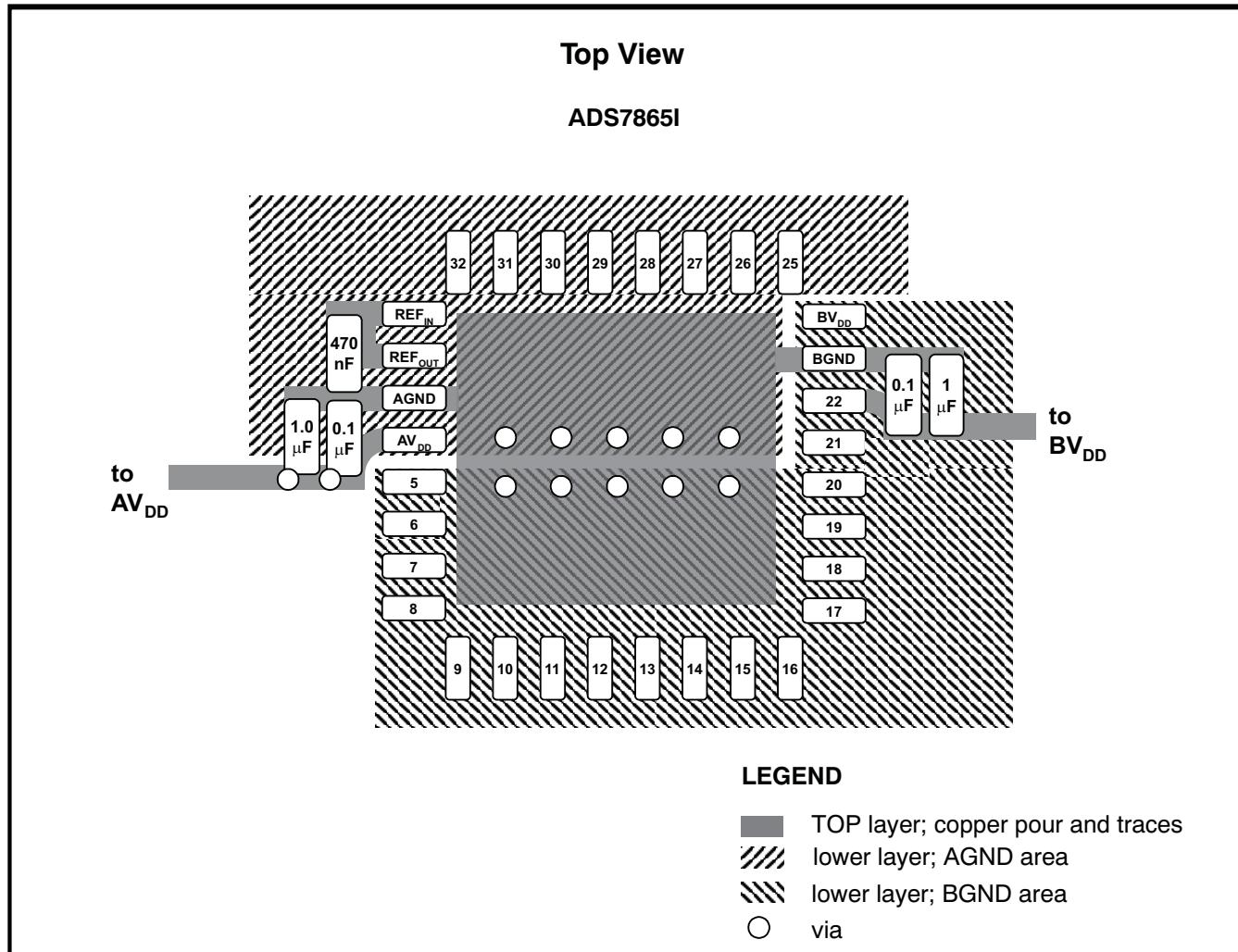


Figure 38. Optimized Layout Recommendation

Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (October 2008) to Revision A

| | Page |
|---|-------------|
| • Changed <i>RESET</i> section of <i>Applications Information</i> | 16 |

PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|--------------|-----------------|------|-------------|-------------------------|------------------|------------------------------|
| ADS7865IPBS | ACTIVE | TQFP | PBS | 32 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |
| ADS7865IPBSG4 | ACTIVE | TQFP | PBS | 32 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |
| ADS7865IPBSR | ACTIVE | TQFP | PBS | 32 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |
| ADS7865IPBSRG4 | ACTIVE | TQFP | PBS | 32 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

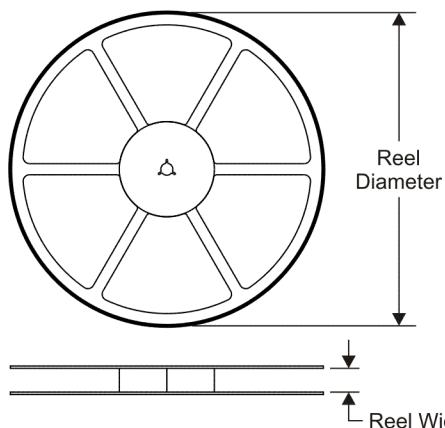
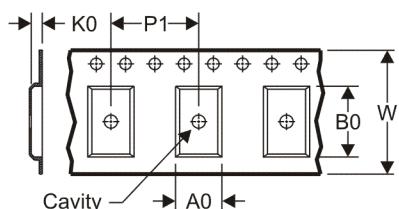
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

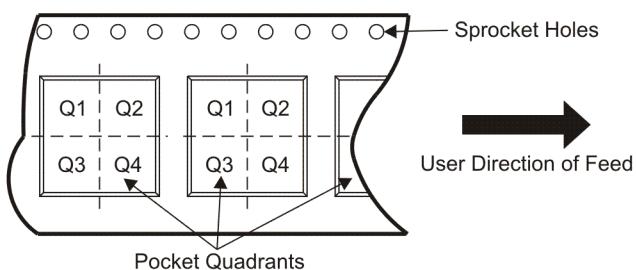
⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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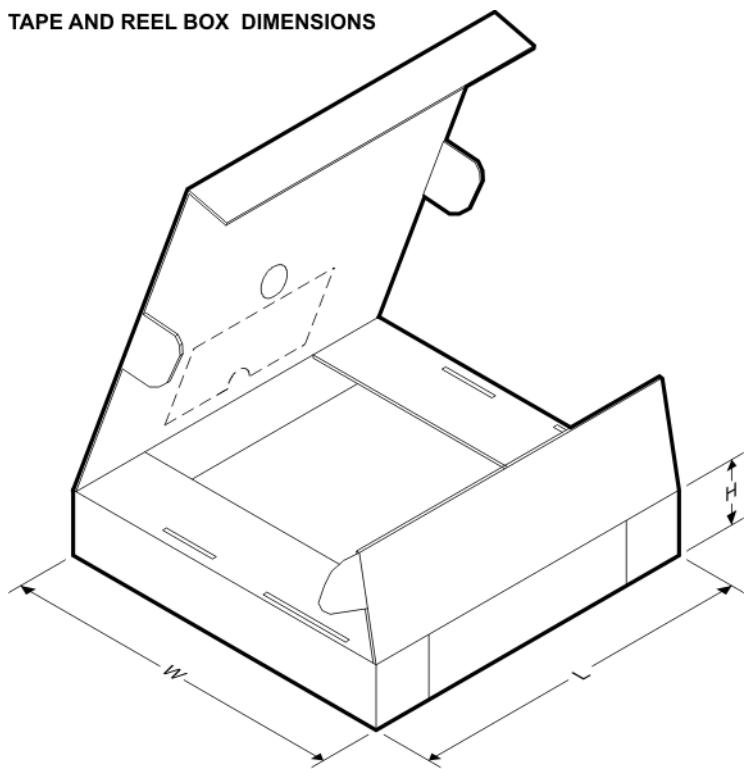
TAPE AND REEL INFORMATION
REEL DIMENSIONS

TAPE DIMENSIONS


| | |
|----|---|
| A0 | Dimension designed to accommodate the component width |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| ADS7865IPBSR | TQFP | PBS | 32 | 2000 | 330.0 | 16.4 | 7.2 | 7.2 | 1.5 | 12.0 | 16.0 | Q2 |

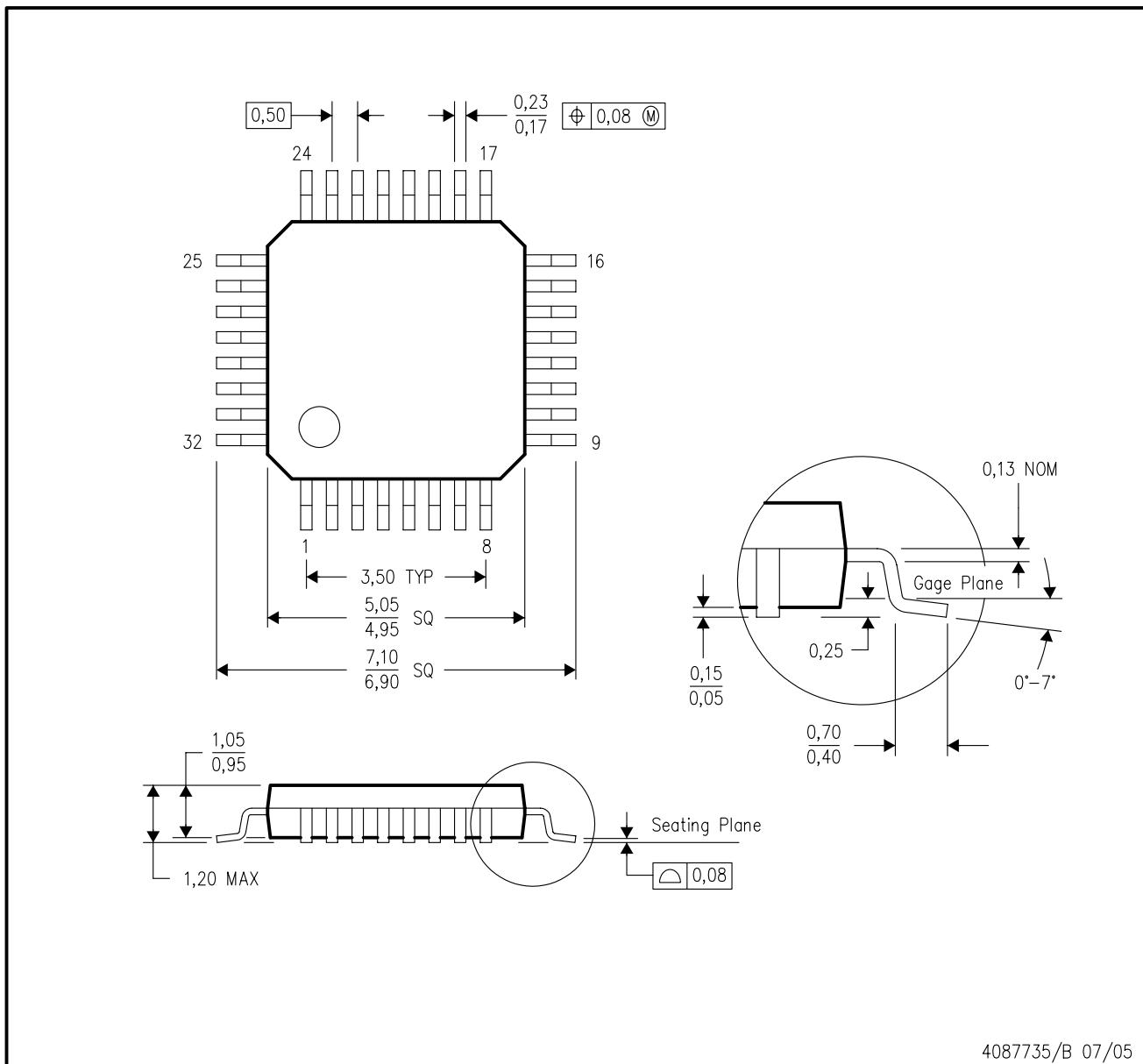
TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ADS7865IPBSR | TQFP | PBS | 32 | 2000 | 346.0 | 346.0 | 33.0 |

PBS (S-PQFP-G32)

PLASTIC QUAD FLATPACK



NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.

4087735/B 07/05

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